

**Notice of References Cited**

Application/Control No.

10/020,710

Applicant(s)/Patent Under

Reexamination

BERTREM ET AL.

Examiner

Brian P Mruk

Art Unit

1751

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,368,146	01-1983	Aronson et al	252/542
	B	US-US 2002/0160924	10-2002	Bertrem et al	510/189
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	N	EP 859,046 A1	08-1998	Europe	Gordon et al	C11D 3/37
*	O	EP 919,610 A1	06-1999	Europe	Pace et al	C11D 3/37
	P	WO 97/03180	01-1997	Europe	Spruyt et al	C11D 17/00
*	Q	WO 95/00611	01-1995	Europe	Fusiak et al	C11D 1/14
*	R	WO 97/33963	09-1997	Europe	Willey et al	C11D 3/37
-	S	WO 00/77144	12-2000	Europe	Sherry et al	C11D 3/37
	T	WO 00/77143	12-2000	Europe	Sherry et al	C11D 3/37

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Brian P. Mruk

12-2-02